

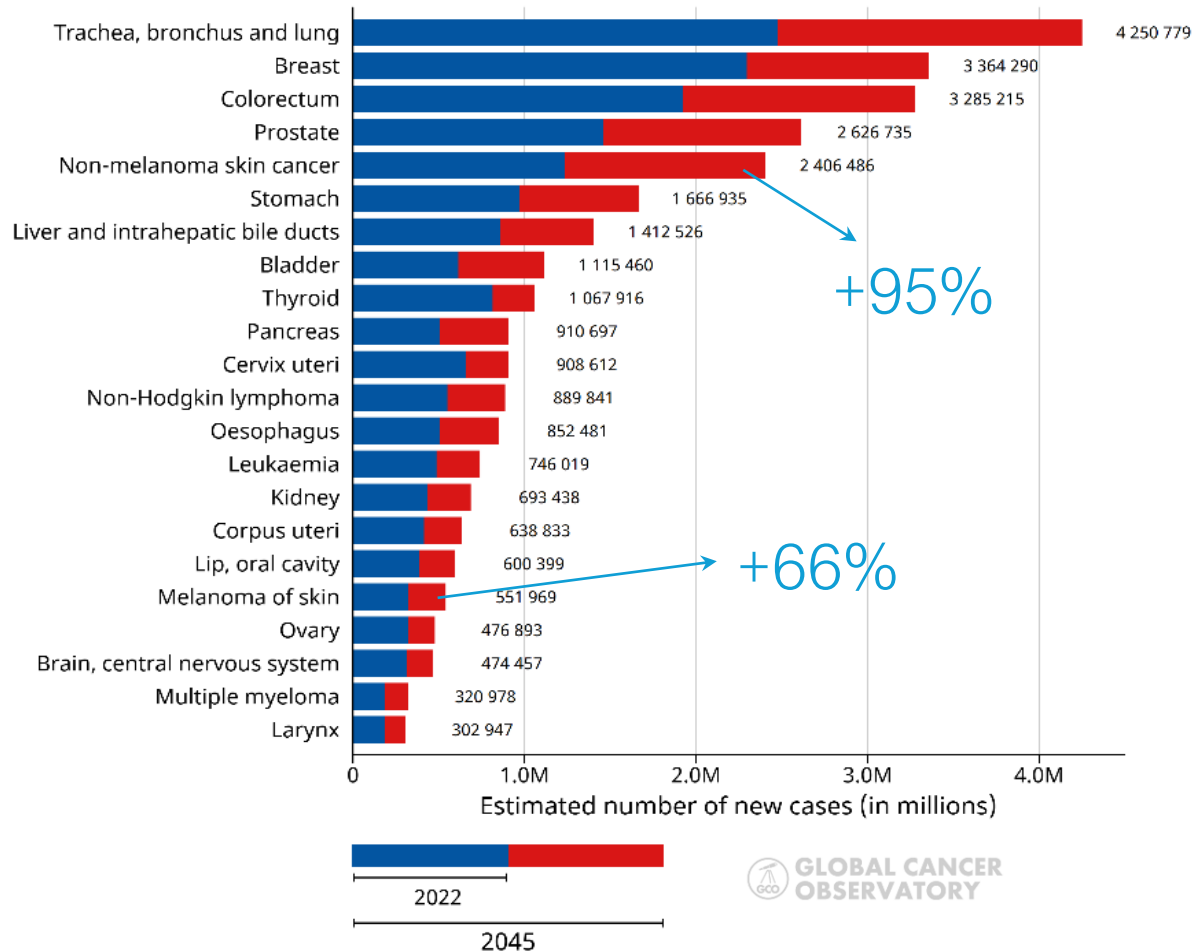


# UNIC-CASS 3<sup>rd</sup> ed. The BASIC Project

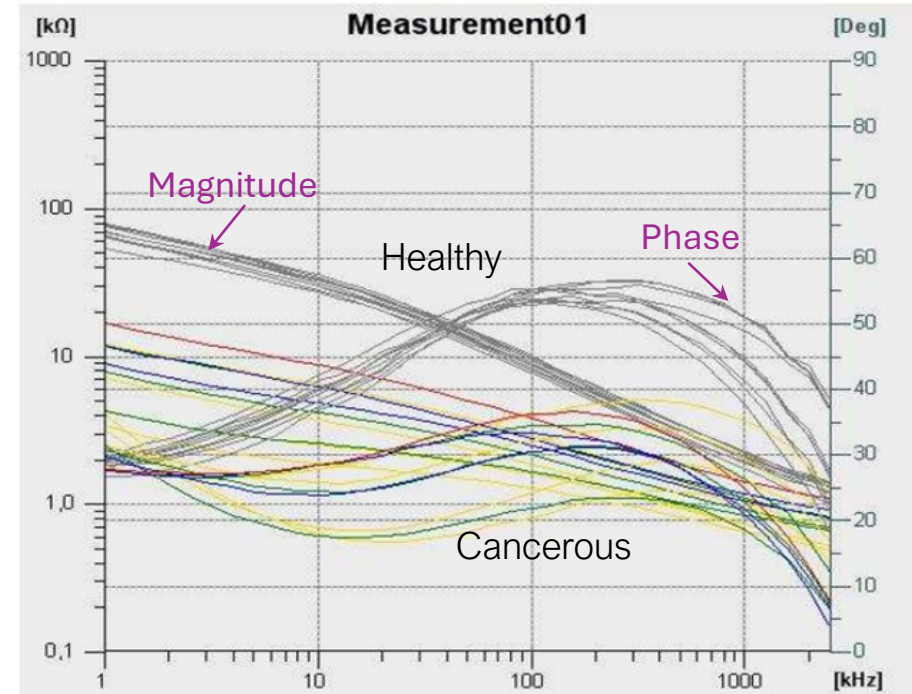
Florianópolis, December 8, 2025

# A problem

## Global cancer growth projections



One more way to help...

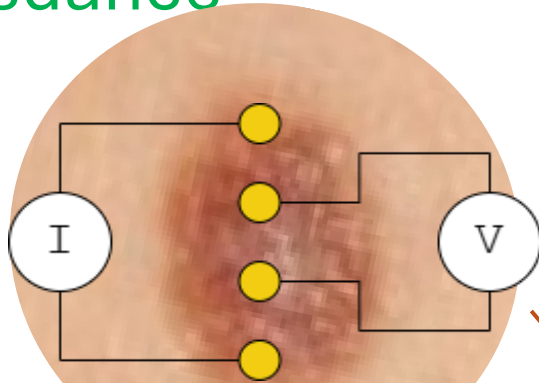


Bioimpedance

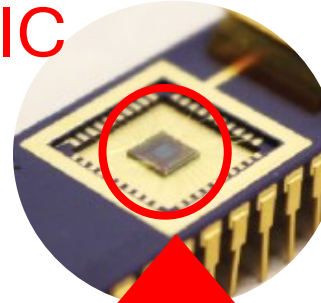
# The BASIC Project



Bioimpedance



ASIC



UNIC-CASS - 2023 (1<sup>st</sup> ed.)

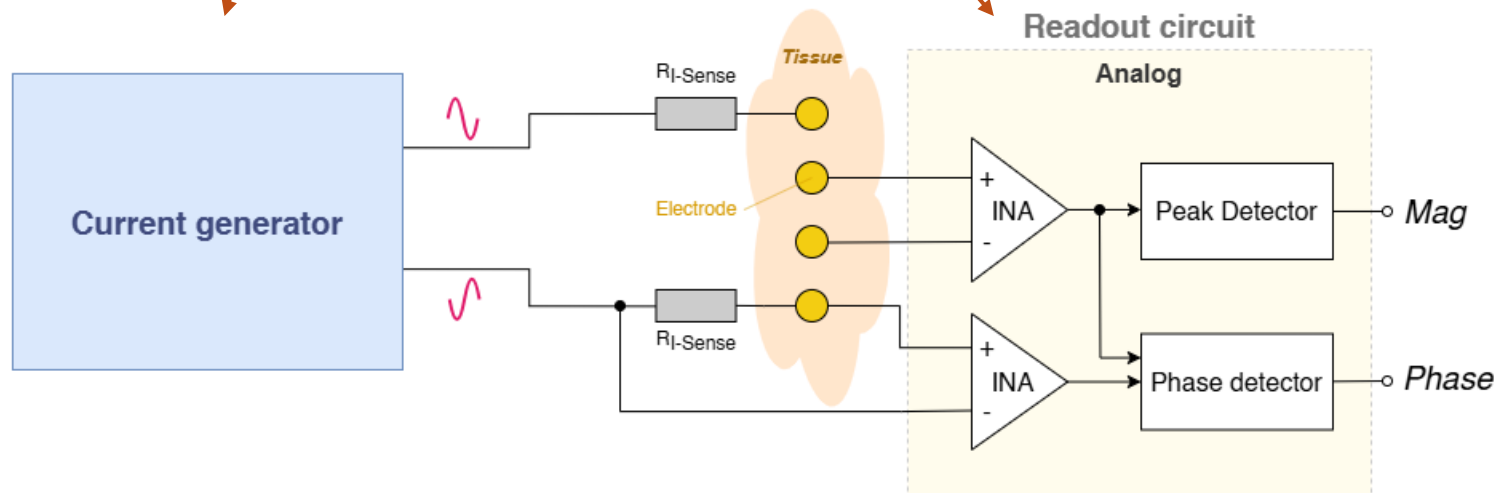
Project: **CAFEINA**

- FDDA circuit (for INA)
- Analog

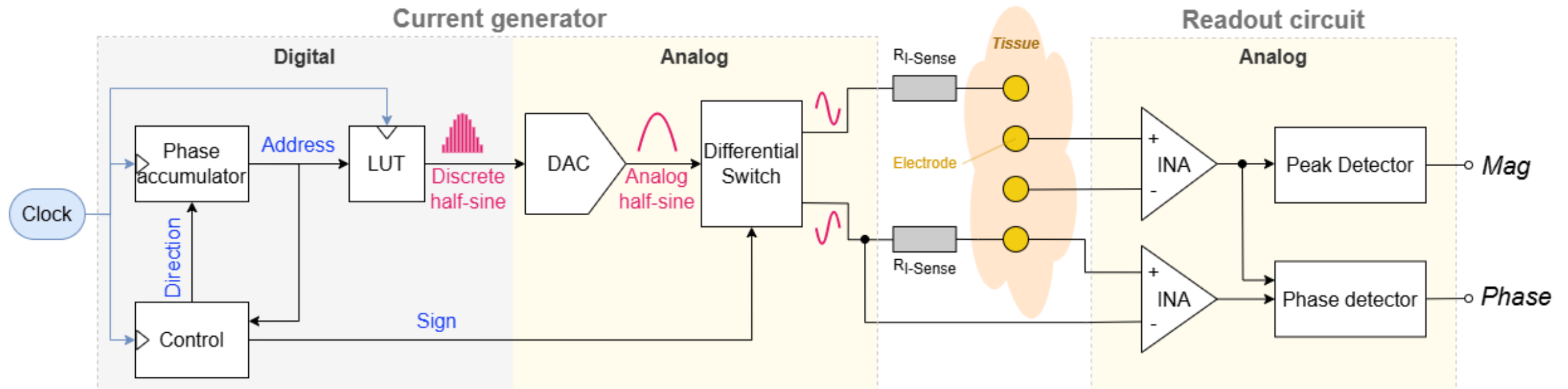
UNIC-CASS - 2024 (2<sup>nd</sup> ed.)

Project: **CAFE**

- Current generator
- Digital + analog

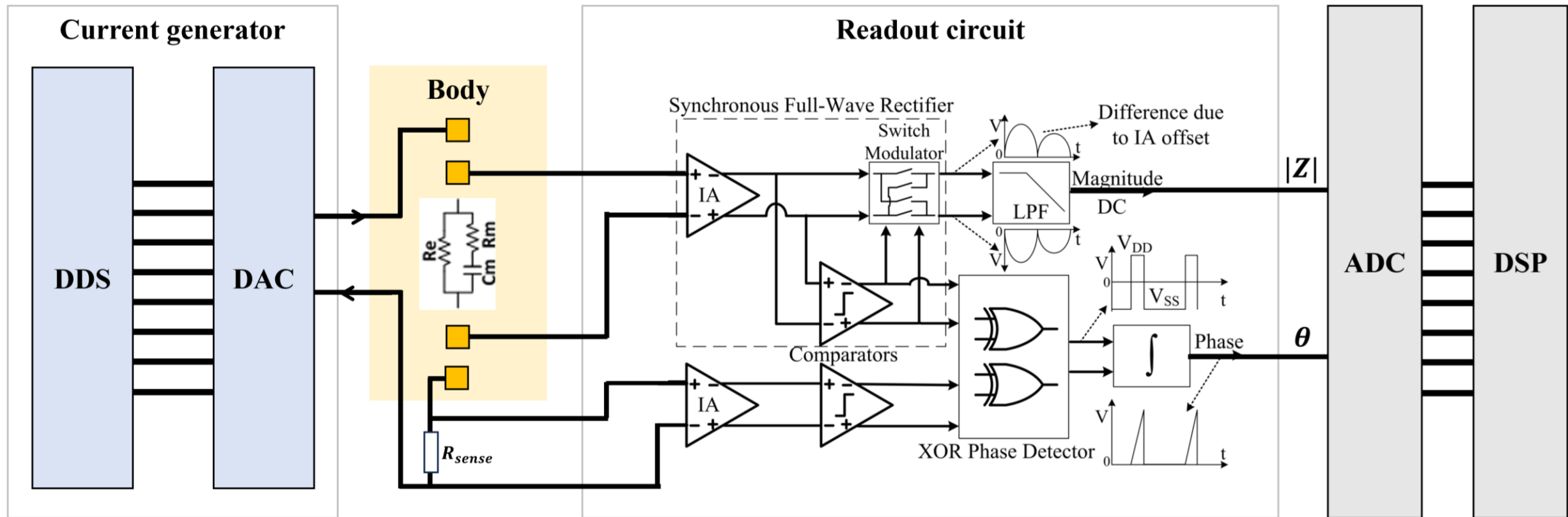


# BASIC – detailed current gen

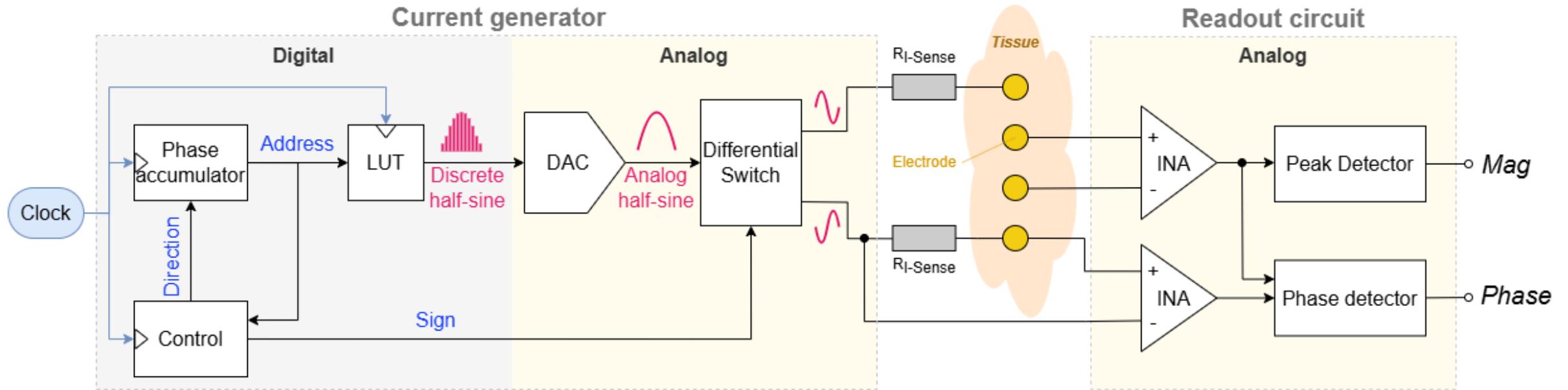


# BASIC - detailed readout

Block diagram of full bioimpedance system



# UNIC-CASS 3<sup>rd</sup> ed. (2025)



## → Plan A

### Current generator

- Digital: FSM+LUT
- Analog: DAC + Diff switch

### Readout circuit

- Analog: INA + Peak detector + Phase detector

## → Plan B

### Current generator

- Digital: FSM+LUT
- Analog: DAC + Diff switch

### Readout circuit

- Analog: INA

## → Plan C

### Current generator

- Digital: FSM+LUT
- Analog: DAC + Diff switch

# Plan A

- 17 pins (min)
- W/out debug points
- W/out test mode selection

## → *Plan A*

### Current generator

- Digital: FSM+LUT
- Analog: DAC + Diff switch

### Readout circuit

- Analog:
  - + INA
  - + Peak detector
  - + Phase detector

#	Pin name	Size	Direction	Domain	Description
1	AVDD	1	IO	Power	Supply for analog domain
2	VSS	1	IO	Ground	Ground
3	DVDD	1	IO	Power	Supply for digital domain
4	CC_P	1	IO	Analog	Positive CC
5	CC_N	1	IO	Analog	Negative CC
6	PU_P	1	IO	Analog	Positive PU
7	PU_N	1	IO	Analog	Negative PU
8	IREF_DAC	1	Input	Analog	DAC reference current
9	IREF_INA	1	Input	Analog	INA reference current
10	IGEN_SEL	1	Input	Digital	Current selector
11	GSEL<1:0>	2	Input	Digital	INA gain selector
12	CLK	1	Input	Digital	1MHz – 510 MHz
13	RST	1	Input	Digital	Rst for digital
14	VCM	1	Input	Analog	External CM voltage
15	EN_AN	1	Input	Digital	Enable for analog blocks
16	Magnitude	1	Output	Analog	Mag output
17	Phase	1	Output	Analog	Phase output

# Plan B

- 15 pins (min)
- W/out debug points
- W/out test mode selection

## → *Plan B*

### Current generator

- Digital: FSM+LUT
- Analog: DAC + Diff switch

### Readout circuit

- Analog: INA

#	Pin name	Size	Direction	Domain	Description
1	AVDD	1	IO	Power	Supply for analog domain
2	VSS	1	IO	Ground	Ground
3	DVDD	1	IO	Power	Supply for digital domain
4	CC_P	1	IO	Analog	Positive CC
5	CC_N	1	IO	Analog	Negative CC
6	PU_P	1	IO	Analog	Positive PU
7	PU_N	1	IO	Analog	Negative PU
8	IREF_DAC	1	Input	Analog	DAC reference current
9	IREF_INA	1	Input	Analog	INA reference current
10	IGEN_SEL	1	Input	Digital	Current selector
11	GSEL<1:0>	2	Input	Digital	INA gain selector
12	CLK	1	Input	Digital	1MHz – 510 MHz
13	RST	1	Input	Digital	Rst for digital
14	VCM	1	Input	Analog	External CM voltage
15	EN_AN	1	Input	Digital	Enable for analog blocks
16	Magnitude	1	Output	Analog	Mag-output
17	Phase	1	Output	Analog	Phase output



# Plan C

- 10 pins (min)
- W/out debug points
- W/out test mode selection

## → Plan C

### Current generator

- Digital: FSM+LUT
- Analog: DAC + Diff switch

#	Pin name	Size	Direction	Domain	Description
1	AVDD	1	IO	Power	Supply for analog domain
2	VSS	1	IO	Ground	Ground
3	DVDD	1	IO	Power	Supply for digital domain
4	CC_P	1	IO	Analog	Positive CC
5	CC_N	1	IO	Analog	Negative CC
6	PU_P	1	IO	Analog	Positive PU
7	PU_N	1	IO	Analog	Negative PU
8	IREF_DAC	1	Input	Analog	DAC reference current
9	IREF_INA	1	Input	Analog	INA reference current
10	IGEN_SEL	1	Input	Digital	Current selector
11	GSEL<1:0>	2	Input	Digital	INA gain-selector
12	CLK	1	Input	Digital	1MHz – 510 MHz
13	RST	1	Input	Digital	Rst for digital
14	VCM	1	Input	Analog	External CM voltage
15	EN_AN	1	Input	Digital	Enable for analog blocks
16	Magnitude	1	Output	Analog	Mag-output
17	Phase	1	Output	Analog	Phase-output

# *IGEN (Current Generator)* - DDS

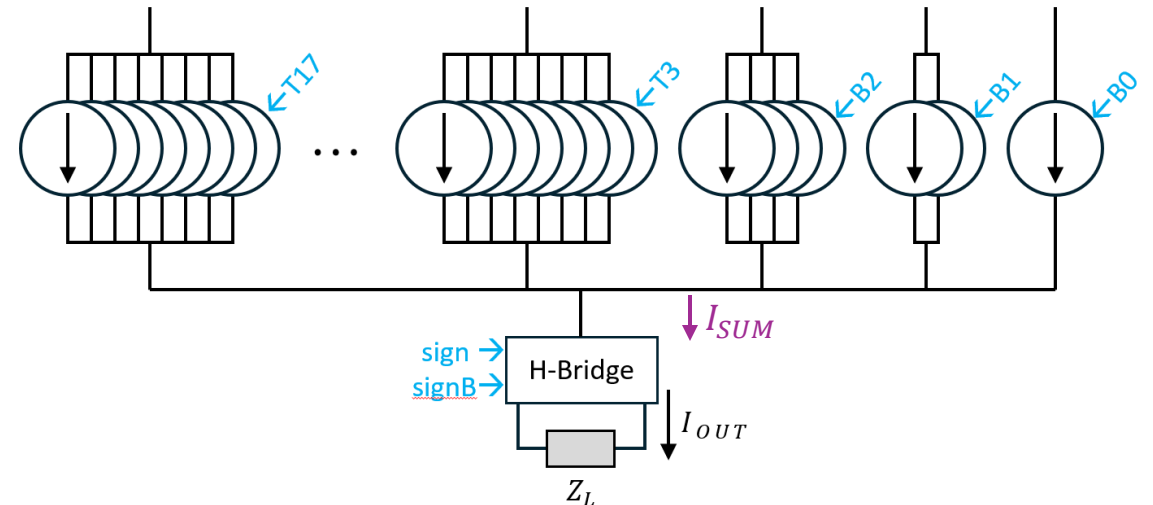
Block	Pin name	Size	Direction	Domain	Description
DDS	CLK	1	Input	Digital	1MHz – 510 MHz
	RST	1	Input	Digital	Rst for digital
	DVDD	1	IO	Power	Supply for digital domain
	SIGN	1	Output	Digital	Control sign of sine
	SIGNB	1	Output	Digital	Complementary control
	SINE_OUT<17:0>	18	Output	Digital	Control for 4T3B- DAC

- Verilog: 6 pins
- DDS for layout: 6 pins + DVDD+DVSS = 8 pins
- W/out debug points
- Verilog for DDS done (no debug or sel mode included)
- If include inverter in DSW input SIGNB could be eliminated.
- If non-overlap circuit added, SIGNB could be eliminated.

# *IGEN (Current Generator) - DAC*

Block	Pin name	Size	Direction	Domain	Description
DAC	AVDD	1	IO	Analog	Supply for analog domain
	AVSS	1	IO	Analog	Ground for analog domain
	IREF	1	IO	Analog	Reference current
	DATA<17:0>	18	Input	Digital	15 thermometric current sources <17:3> 3 binary current sources <2:0>
	SEL_IGEN	1	Input	Digital	Current selector
	EN_AN	1	Input	Digital	Enable for analog blocks
	ISUM<17:0>	18 or 1	Output	Analog	Analog output

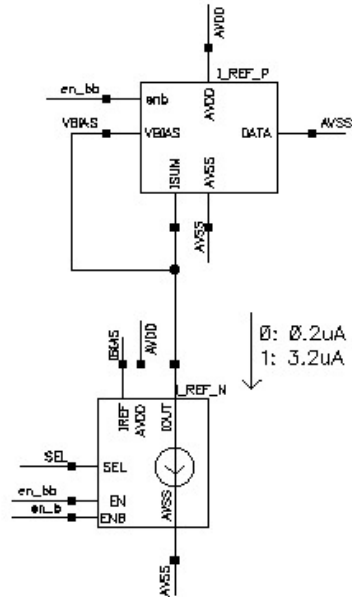
- 4T3B DAC: 15 thermometric current sources <17:3>  
3 binary current sources <2:0>
- ISUM could be short circuited, since output goes to 1 size input of DSW.
- Total: 24 pins (min) or 41 pins (ISUM<17:0>)



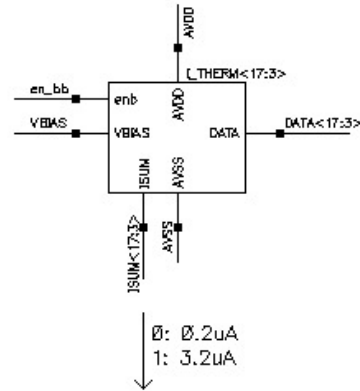
# IGEN (Current Generator) - DAC

## 7-BIT SEGMENTED CURRENT STEERING DAC

### REFERENCE CURRENT

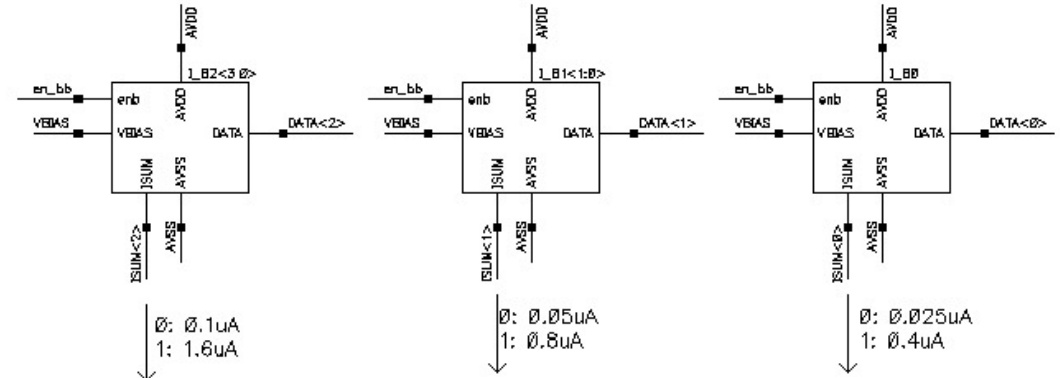


### THERMOMETRIC DAC



4 BITS

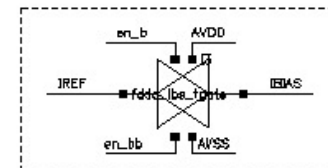
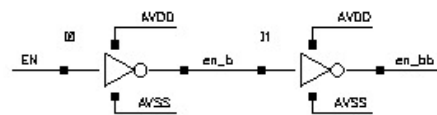
### BINARY DAC



3 BITS

POWER	BIAS	INPUT	OUTPUT
AVDD	IREF	SEL	ISUM<17:0>
AVSS		EN	
		DATA<17:0>	

### ENABLE

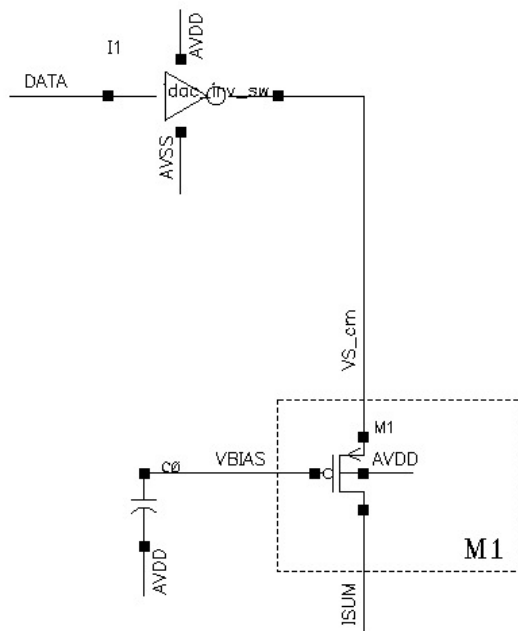


# IGEN (Current Generator) - DAC

## 7-BIT SEGMENTED CURRENT STEERING DAC

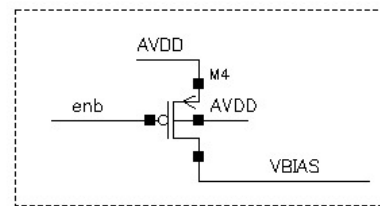
### REFERENCE CURRENT

#### iDAC UNIT

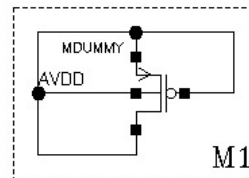


### THERMOMETRIC DAC

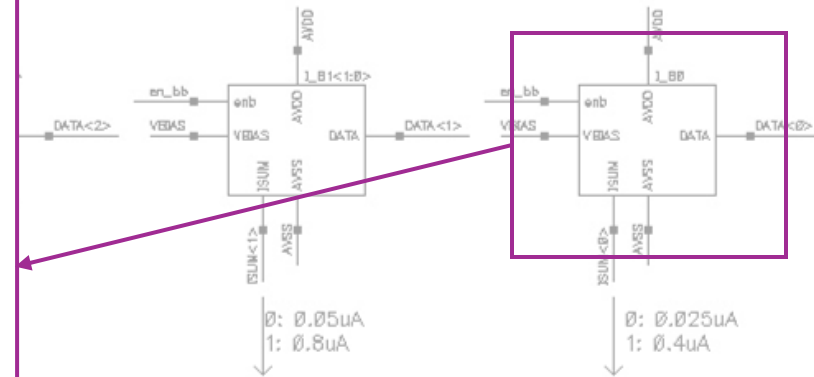
#### ENABLE



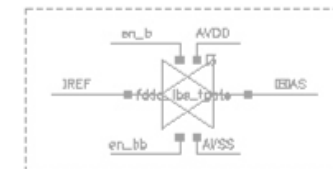
#### DUMMY DEVICES



### BINARY DAC



3 BITS

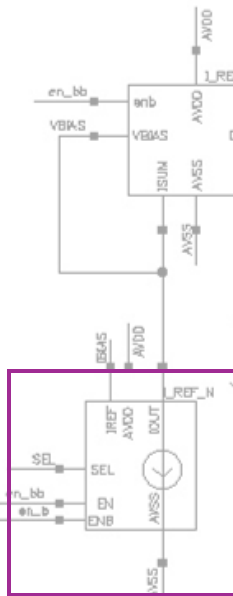


$$\text{TSMC65: } \left(\frac{W}{L}\right)_{M1} = \frac{2 \times 2 \times 0.360 \mu m}{2 \mu m}$$

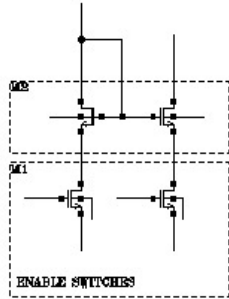
# IGEN (Current Generator) - DAC

7-BIT SEGMENT

REFERENCE



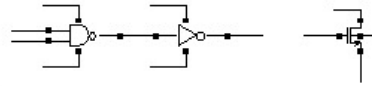
CURRENT MIRROR 1:1



1: 3.2uA

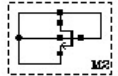
- (i) Notes
1. Enable and selector switches are the same.
  2. 15 current mirrors with SEL switch.
3. Operations:
- \* When SEL = 0, IOUT = IREF (0.2uA)
  - \* When SEL = 1, IOUT = 16xIREF (3.2uA)

ENABLE / SEL

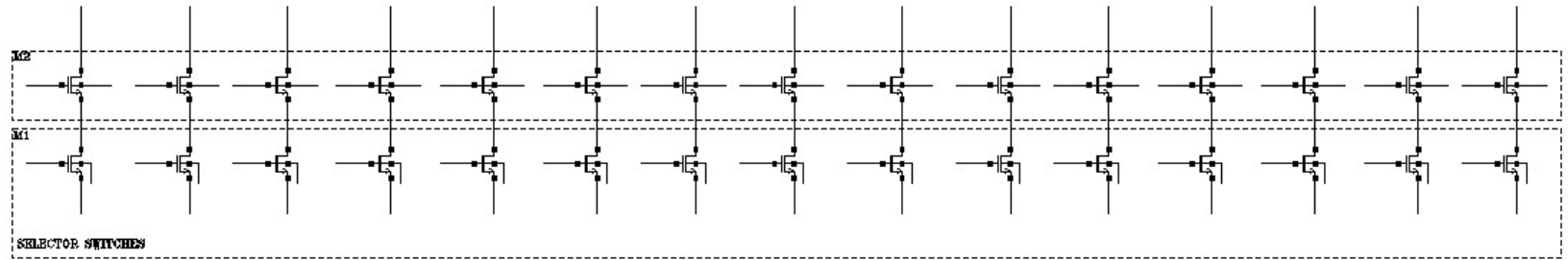


- (ii) Notes:
- \* Add dummies as needed for matching.
  - \* The matching scheme is marked by the name M1.
  - \* 1 being the corresponding number.
  - \* All devices delimited by the same area should match each other.
  - \* If visibility is compromised, please disable visualization of notes.

DUMMY DEVICES



CURRENT MIRROR 1:16



1: 3.2uA

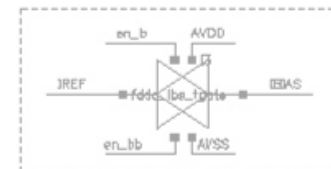
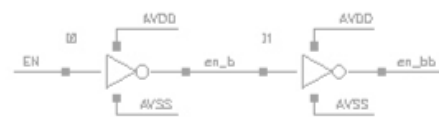
1: 1.00uA

4 BITS

3 BITS

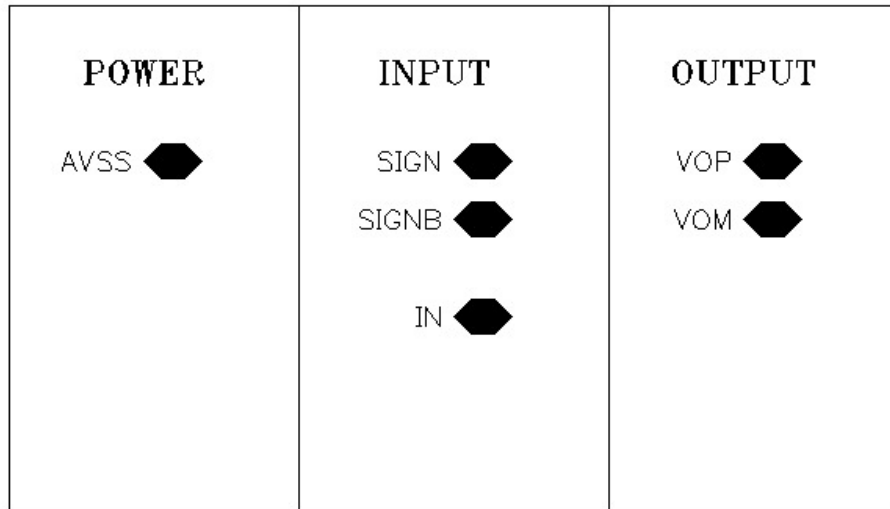
POWER	BIAS	INPUT	OUTPUT
AVDD	IREF	SEL	
AVSS		EN	
		DATA<17:0>	ISUM<17:0>

ENABLE

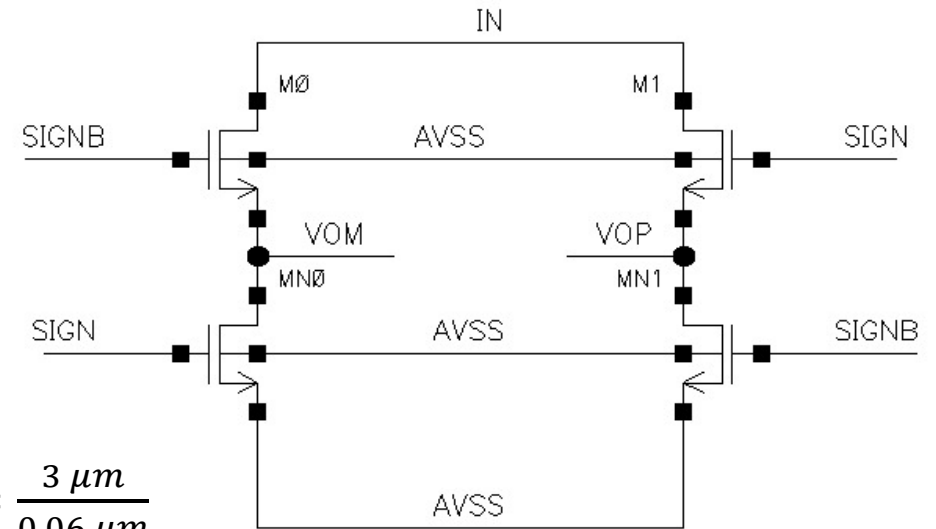


# *IGEN (Current Generator) - DSW*

Block	Pin name	Size	Direction	Domain	Description
DSW	AVDD		IO	Power	Supply for analog domain
	AVSS		IO	Power	Ground for analog domain
	IN		Input	Analog	ISUM from DAC
	VOP		Output	Analog	Positive Output
	VOM		Output	Analog	Negative Output



$$\text{TSMC65} : \frac{W}{L} = \frac{3 \mu m}{0.06 \mu m}$$



# VREAD (Readout circuit) - INA

For Bioimpedance measurements:

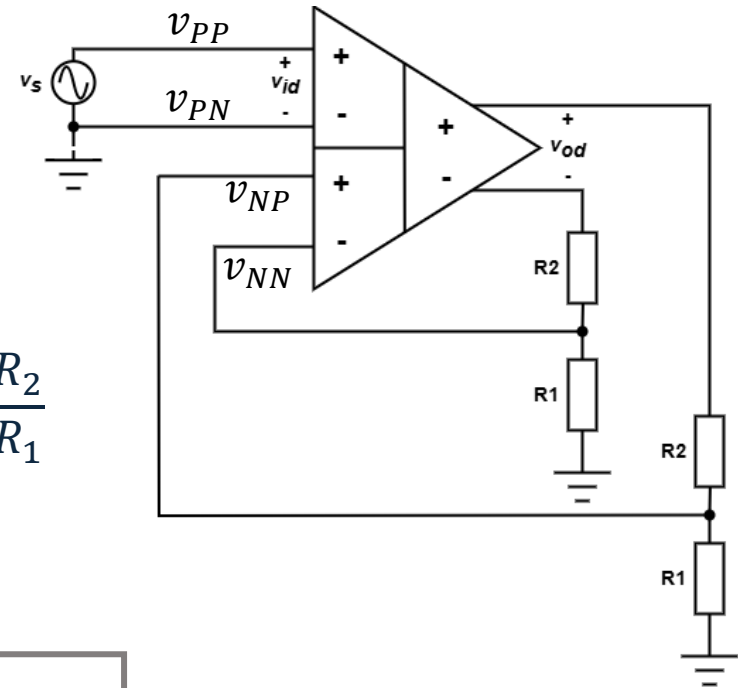
✚ Typical range 1 kHz – 1 MHz

INA must have

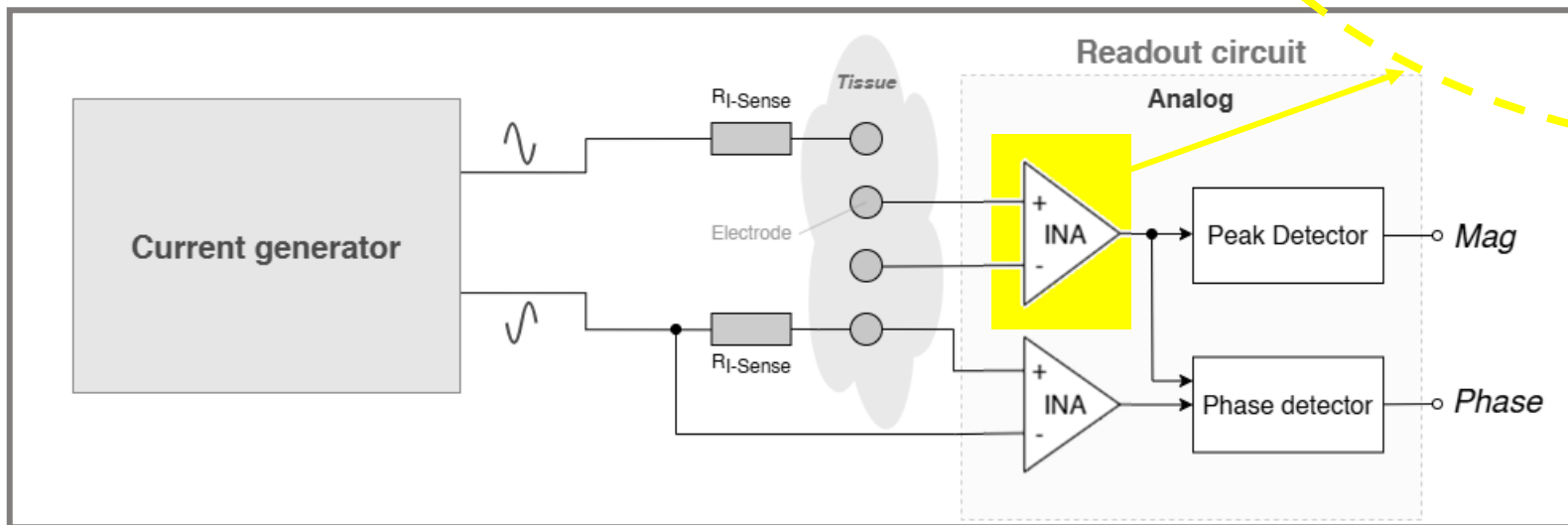
✚ High GBW, CMRR, PSRR

✚ Adjustable gain: 1 (buffer), 5V/V, 25 V/V

$$\frac{v_{od}}{v_{id}} = 1 + \frac{R_2}{R_1}$$

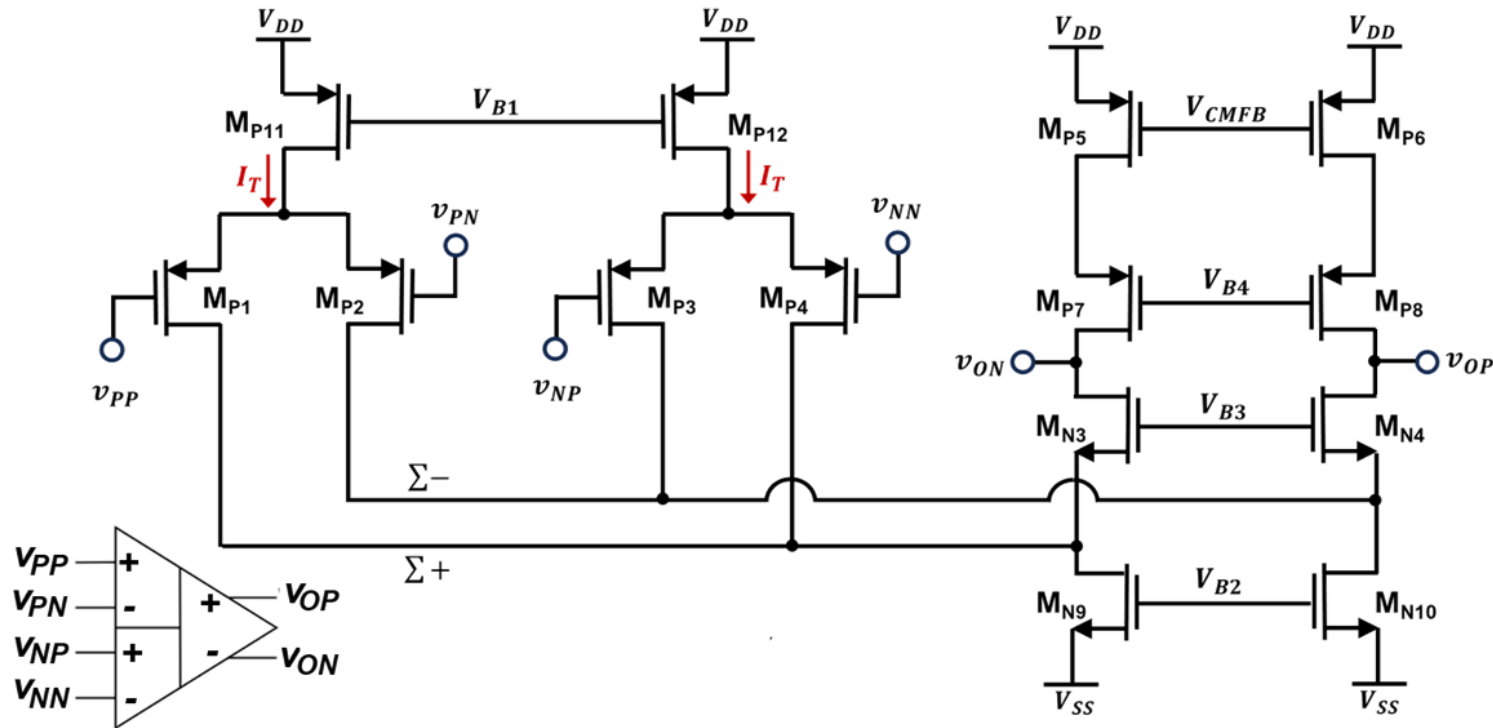


Fully Differential Difference  
Amplifier  
(FDDA)-based INA





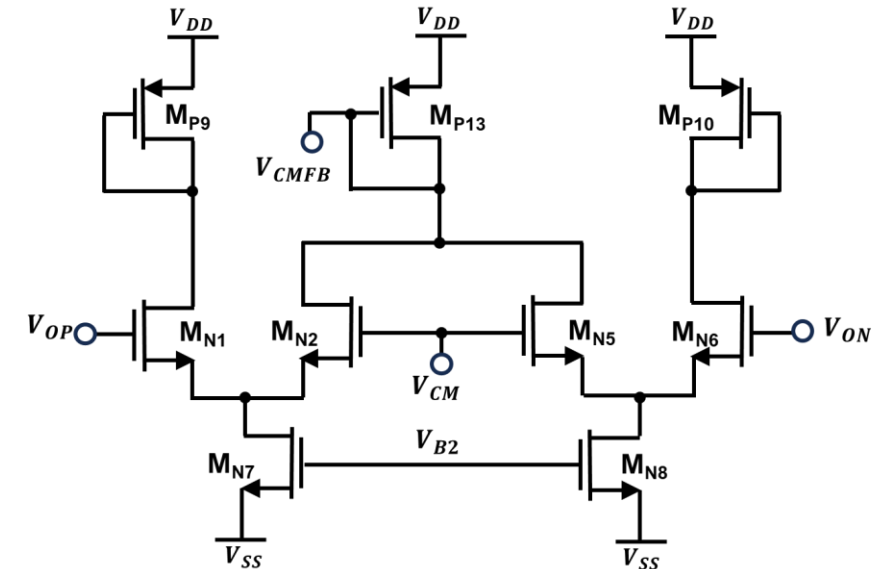
# VREAD (Readout circuit) – INA (FDDA)



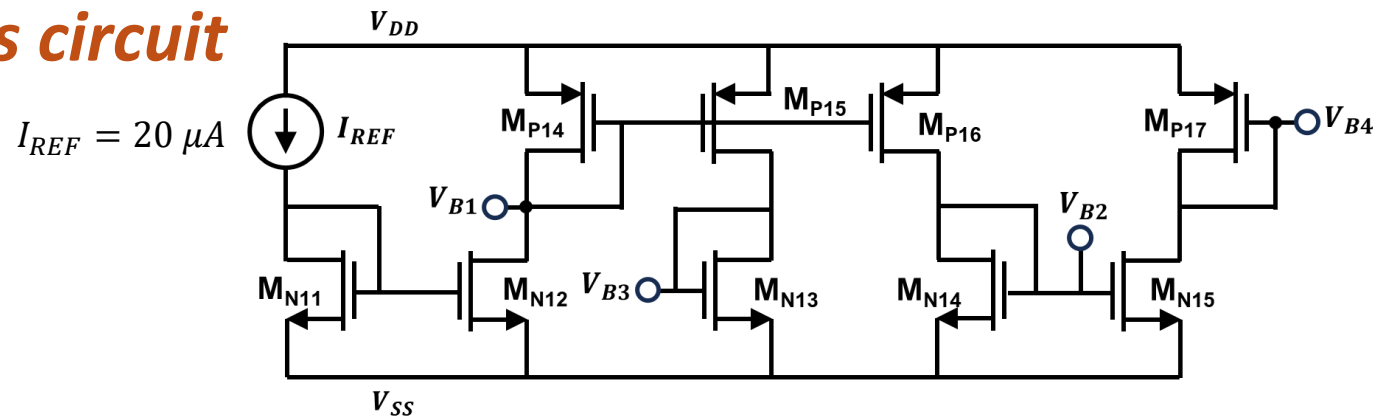
Desired:

- $V_{in}$  &  $v_{out}$  max diff swing:  $-0.4V - 0.4V$   
*Depends on tech vdd*
- $V_{os} < 2mV$
- $GBW > 30MHz$  (best if 50MHz)

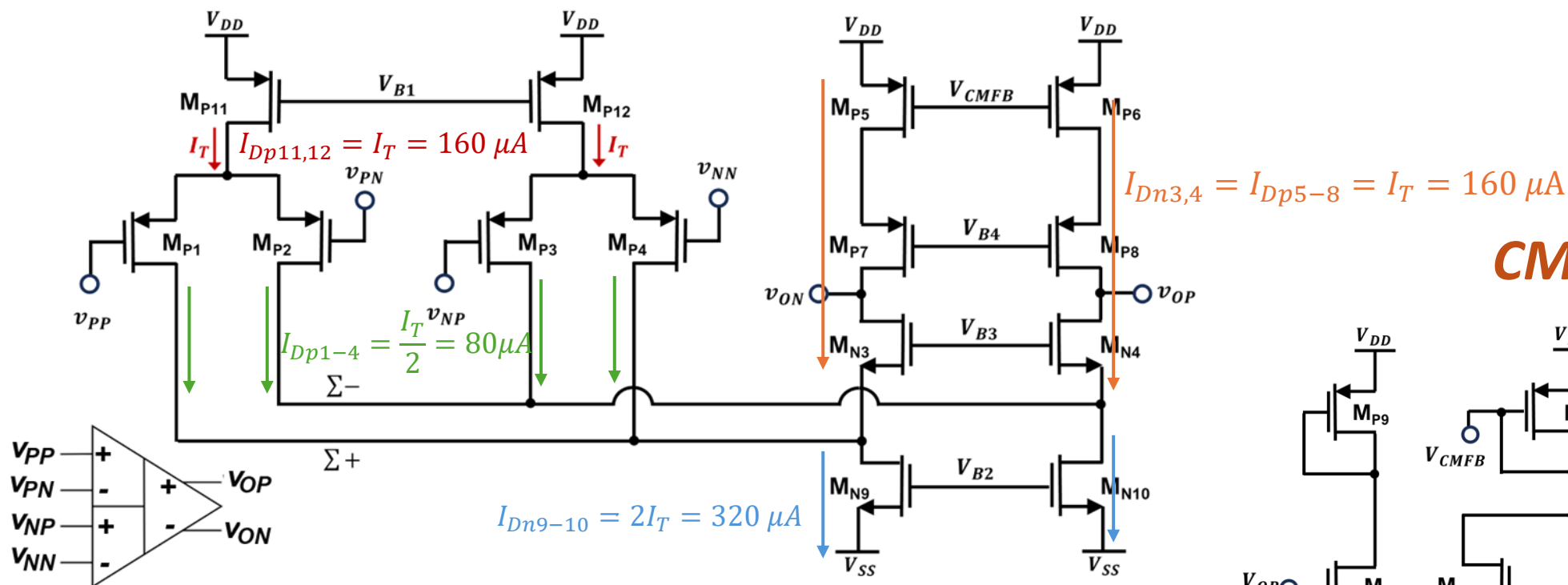
**CMFB**



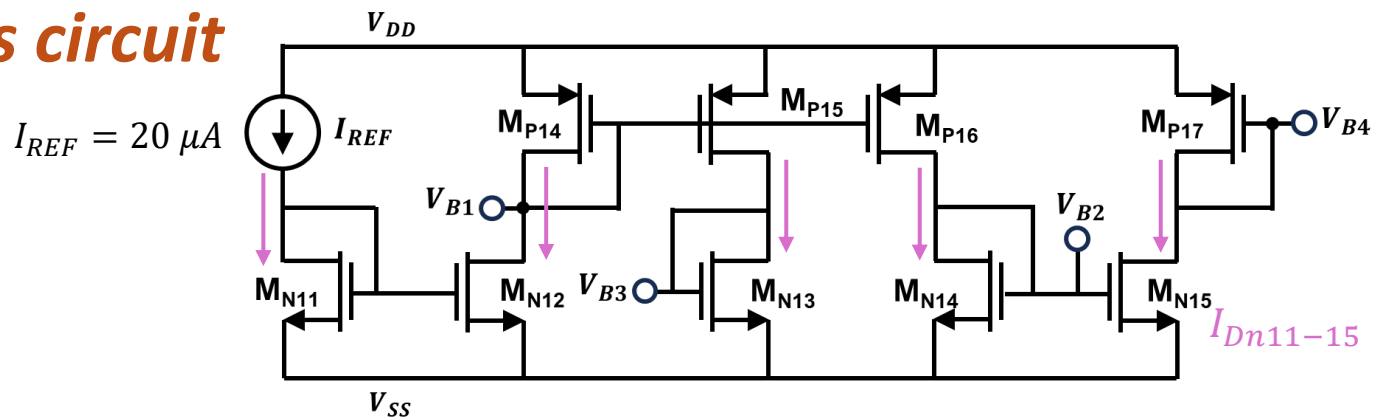
**Bias circuit**



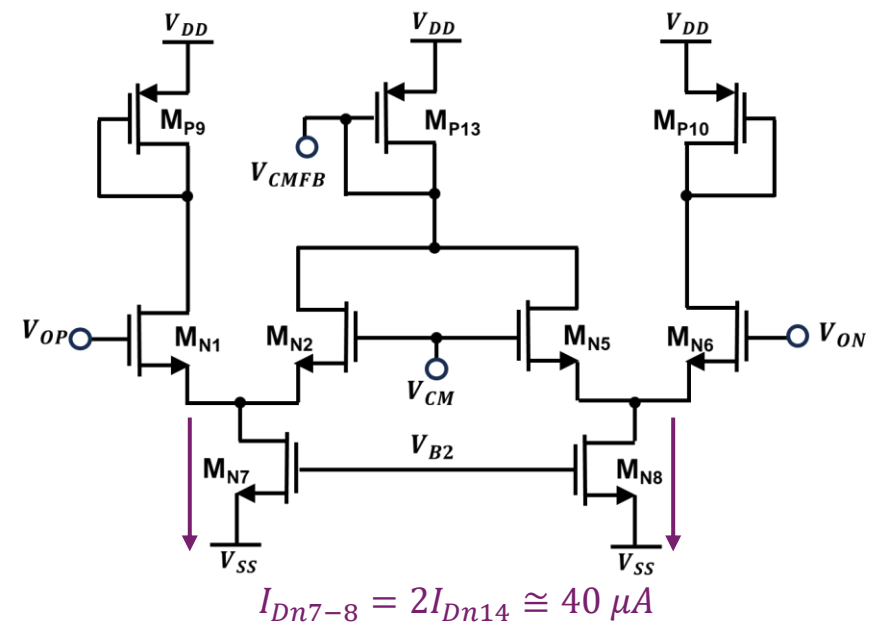
# VREAD (Readout circuit) – INA (FDDA)



## *Bias circuit*

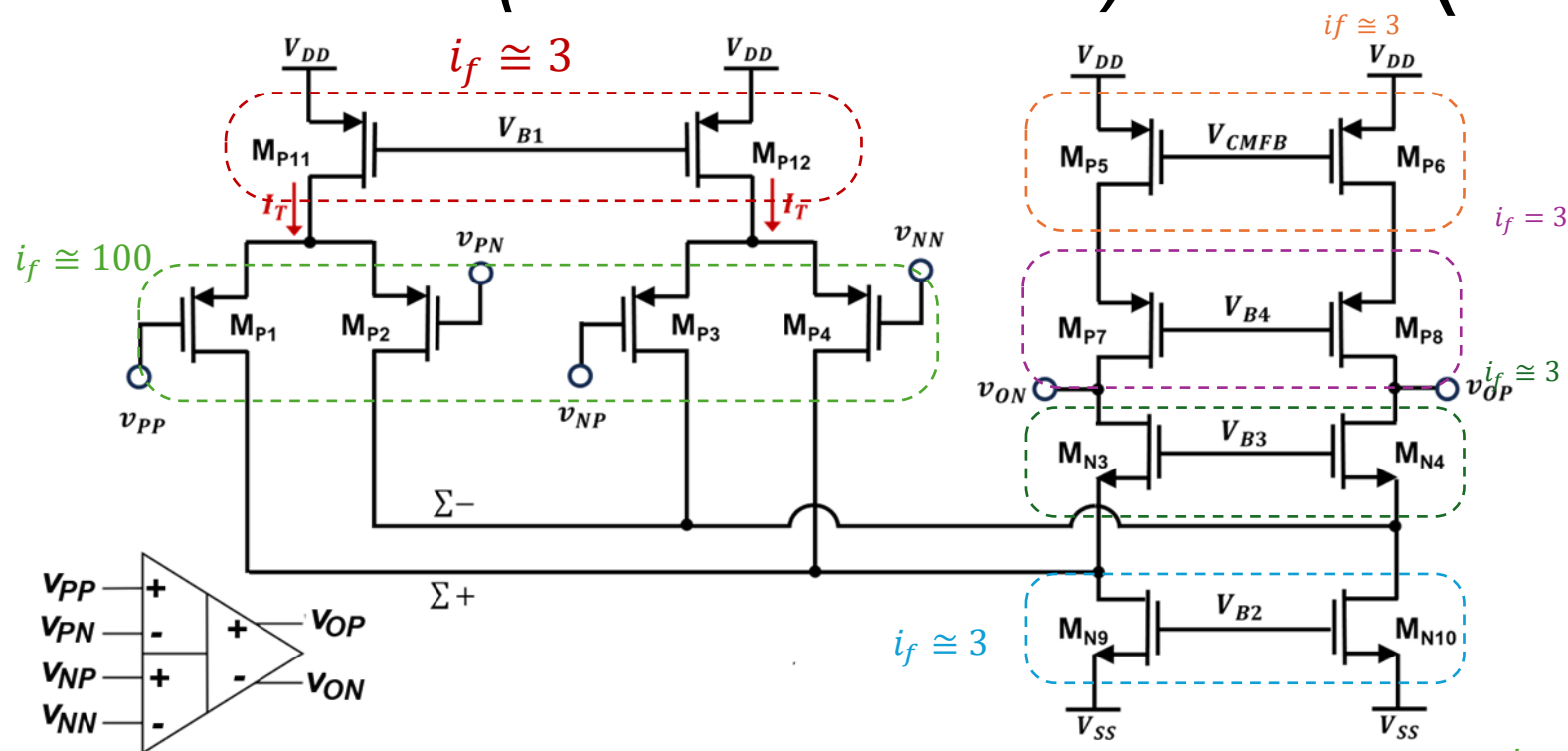


**CMFB**

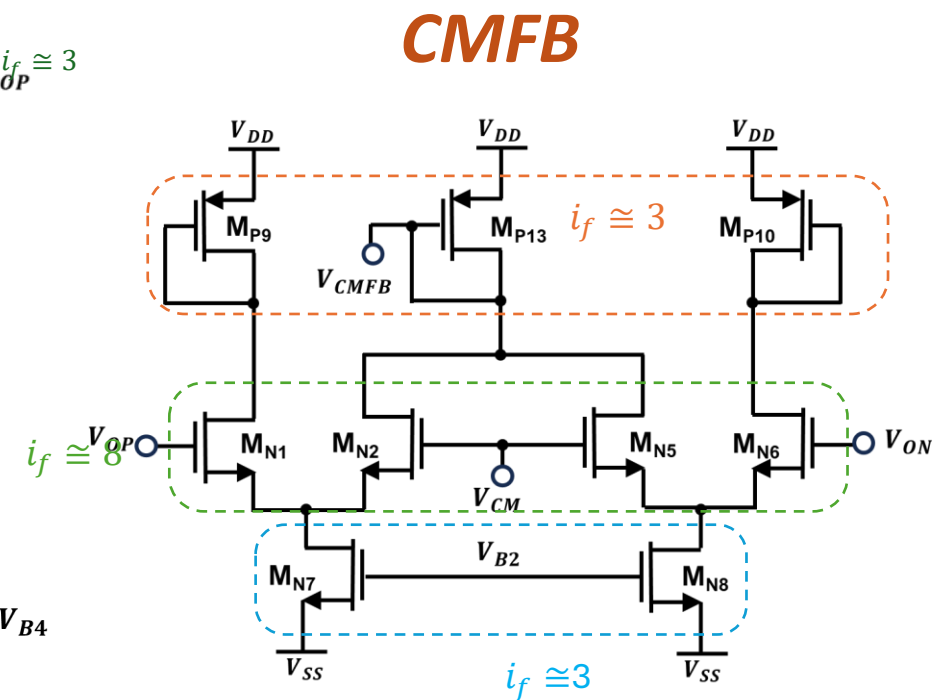
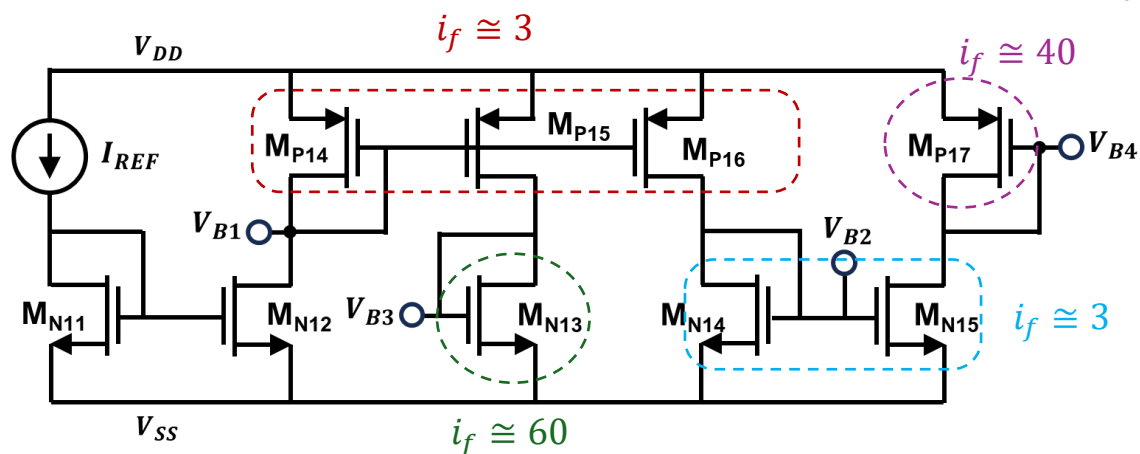


$$^{15}I_{Dn11-15} = I_{Dp14-17} = \frac{I_T}{8} \cong 20 \mu A$$

# VREAD (Readout circuit) – INA (FDDA)



## Bias circuit



# *VREAD* (Readout circuit) – INA (FDDA)

	Device	Type	ID [uA] (ideal)	if (ideal)	W [um] (tot) m x nf x W	L [um] (tot) Series x L	S (calculated)
Input pair	MP1-4	P-lvt	80	100	24x2x0.5=24	2	12
Itail P	MP11-12	P-svt	160	3	128x4x3.5=1792	2	896
	MP5-6	P-svt	160	3	128x4x3.5=1792	2	896
	MP7-8	P-svt	160	3	64x4x3.5=896	1	896
Current source N	MN9-10	N-lvt	320	3	256x4x2	2	1024
Cascode N	MN3-4	N-lvt	160	3	80x4x1.6=512	2	512
Bias P	MP14-16	P-svt	20	3	16x4x3.5=224	2	112
Bias P	MP17	P-svt	20	40	9x4x3.5=126	8x2=16	7.88
Bias N	MN14-15	N-lvt	20	3	16x4x2=128	2	64
Bias N	MN16	N-lvt	20	60	8x4x1.6=51.2	8x2=16	3.2
CMFB pair	MN1-2,5-6	N-lvt	20	8	24x2x1.5=72	0.5	144
CMFB tail	MN7-8	P-svt	40	3	32x4x2=256	2	128
CMFB P	MP9-10	P-svt	20	3	16x4x3.5=224	2	112
CMFB P	MP13	P-svt	40	3	32x4x3.5=224	2	224

# UNIC-CASS: Schedule

Date	Activity
Aug 4 <sup>th</sup> , 2025	First Call for Participation
Aug 24 <sup>th</sup> , 2025	Deadline for Proposal submission
Oct 28 <sup>th</sup> , 2025	Result announcement
Dec 4 <sup>th</sup> – March 2026	- Learn from specially curated educational materials - Design-to-Tapeout Mentoring sessions
End of March, 2026	Deadline for Layout submission (IHP)
Sept 2026	Chip test/bring-up

# UNIC-CASS: Schedule

## Main Design-to-tapeout milestones

- ▶ First design review (mock tapeout)
  - Purpose: Prepare the teams in advance for the final tape-out phase
    - **GO/NOGO milestone!**
  - Date: Jan 19
- ▶ Second design review (first DRC/LVS clean design delivery)
  - Purpose: Verify feasibility of designs and top integration
    - **GO/NOGO milestone!**
  - Date: Mar 9
- ▶ UNIC-CASS tapeout
  - Purpose: Final delivery of top designs (GDS+schematic+checks)
  - Date: Mar 27

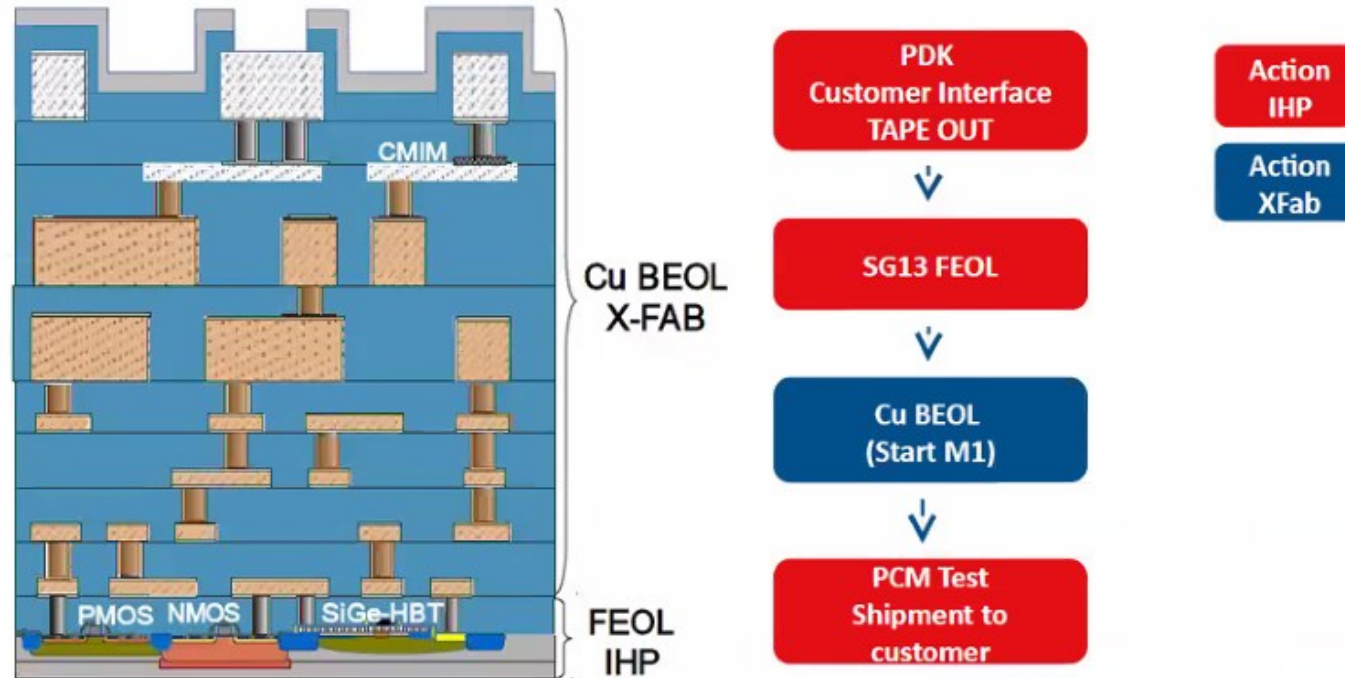
JANEIRO						
D	S	T	Q	Q	S	S
				1	2	3
4	5	6	7	8	9	10
11	12	13	14	15	16	17
18	19	20	21	22	23	24
25	26	27	28	29	30	31

FEVEREIRO						
D	S	T	Q	Q	S	S
1	2	3	4	5	6	7
8	9	10	11	12	13	14
15	16	17	18	19	20	21
22	23	24	25	26	27	28

MARÇO						
D	S	T	Q	Q	S	S
1	2	3	4	5	6	7
8	9	10	11	12	13	14
15	16	17	18	19	20	21
22	23	24	25	26	27	28
29	30	31				

# UNIC-CASS: Tech

## [New] IHP 130nm CMOS technology



- ▶ <https://www.ihp-microelectronics.com/services/research-and-prototyping-service/mpw-prototyping-service/sigec-bicmos-technologies>
- ▶ <https://github.com/IHP-GmbH/IHP-Open-PDK>

# UNIC-CASS: Tech

## [New] IHP 130nm CMOS technology

- ▶ SG13G2 is a high performance BiCMOS technology with a 0.13  $\mu\text{m}$  CMOS process
- ▶ 2 gate oxides: A thin gate oxide for the 1.2 V digital logic and a thick oxide for a 3.3 V supply voltage
- ▶ PMOS and isolated NMOS transistors are offered
- ▶ Passive components like poly silicon resistors and MIM capacitors are available
- ▶ 5 thin metal layers, two thick metal layers (2 and 3  $\mu\text{m}$  thick) and a MIM layer



# UNIC-CASS: Mentoring

- IHP process
- Tool support
- Sim support
- Chip top

Exclusive mentor



Gabriel Maranhão  
IMEC (Belgium)

## Design-to-Tapeout Mentoring Team 2025



Luighi Viton (PE)



Daniel Arévalos, HM (DE)



Deni Alves  
UGA (France)/UFSC (BR)



Francisco Brito  
UFERSA (BR)



Rodrigo Wuerdig  
KUL (BE)/UFRGS (BR)



Jorge Marin  
PUCV (CL)



Sergio Bampi  
UFRGS (BR)



Duy-Hieu Bui,  
VNU Hanoi (VN)



Manuel Monge  
PUCP/OpenIC (PE/US)

# UNIC-CASS: Mentoring

## *Weekly mentoring sessions (1)*

Activities	Date/ Deadline	Purpose/ comments	Your Deliverables (provide info/links on your GitHub)	We will provide/handle
1st Meet-up	Dec 4, TBD UTC	Kick-off meeting	N/A	N/A
Biweekly meet-ups. 1st round	11/12, 25/12, 8/1, 22/1 1 - 2 pm UTC (8am Eastern Time)	Short presentations on topics such as IHP technology, UNIC- CASS Docker, best practices and pitfalls to avoid for both analog and digital. Mentoring and Design groups to present progress.	N/A	Slides and videos will be posted on the UNI-CASS website
1st Design submission [Mock tape-out]	Jan 19	Prepare the teams in advance for the final tape-out phase	Passing mock tapeout report	1. Detailed instructions for mock tapeout 2. Example files
1st Design Review & Feedback	Jan 22	Provide feedback and advice for the next stages	N/A	Feedback on the mock tapeout work
Biweekly meet-ups, 2 <sup>nd</sup> round	6/2, 20/2, 6/3, 20/3 1 - 2 pm UTC (8am Eastern Time)	Focused mentoring + preparation for final tape-out + evaluate status of potential drop-outs	N/A	Slides and videos will be posted on the UNI-CASS website

# UNIC-CASS: Mentoring

## *Weekly mentoring sessions (2)*

Activities	Date/ Deadline	Purpose/ comments	Your Deliverables (provide info/links on your GitHub)	We will provide/handle
2nd Design submission		Verify feasibility of designs and Mar 2 top integration	Detailed circuit description (pinout, area and functionality) + DRC/LVS reports of top design	Check reports to confirm all blocks are LVS and DRC clean.
2nd Design Review & Feedback from mentors		Provide feedback and advice for Mar 6 the final stages	N/A	Feedback on the individual designs + advice for top merge
IHP pre-check + tapeout		Complete tape-out work on IHP Mar 27 platform	Deliver COMPLETE multiproject chip drop-ins to IHP final check	Provide assistance to tape- out leaders within the teams
Tape-out		See: <a href="https://www.ihp-microelectronics.com/services/research-and-prototyping-service/mpw-prototyping-service/low-cost-open-source-mpw-access-1">https://www.ihp-microelectronics.com/services/research-and-prototyping-service/mpw-prototyping-service/low-cost-open-source-mpw-access-1</a> Mar 30	N/A	List of winner teams included in this tapeout List of unfinished designs to candidate for 2026 UNIC-CASS program
Chip delivery date	October 2026	TBD	N/A	Chip shipping and testing logistics

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## Specific mentoring sessions

- ▶ IHP PDK + environment → Krzysztof Herman (IHP)
- ▶ Educational material → Duy-hieu Bui (VNU Hanoi, Vietnam)
- ▶ Digital Flow → Rodrigo Wuerdig + Daniel Arévalos
- ▶ Analog Flow → Deni Alves + Jorge Marin
- ▶ Tapeout pitfalls and best practices in IC design → Manuel Monge
- ▶ Other sessions? We are open to proposals!